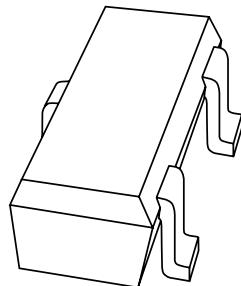


DATA SHEET



1PS193 High-speed diode

Product specification
Supersedes data of April 1996

1996 Sep 11

High-speed diode**1PS193****FEATURES**

- Small plastic SMD package
- High switching speed: max. 4 ns
- Continuous reverse voltage: max. 80 V
- Repetitive peak reverse voltage: max. 85 V
- Repetitive peak forward current: max. 500 mA.

DESCRIPTION

The 1PS193 is a high-speed switching diode, fabricated in planar technology, and encapsulated in the small plastic SMD SC59 package.

PINNING

PIN	DESCRIPTION
1	anode
2	not connected
3	cathode

APPLICATIONS

- High-speed switching in e.g. surface mounted circuits.

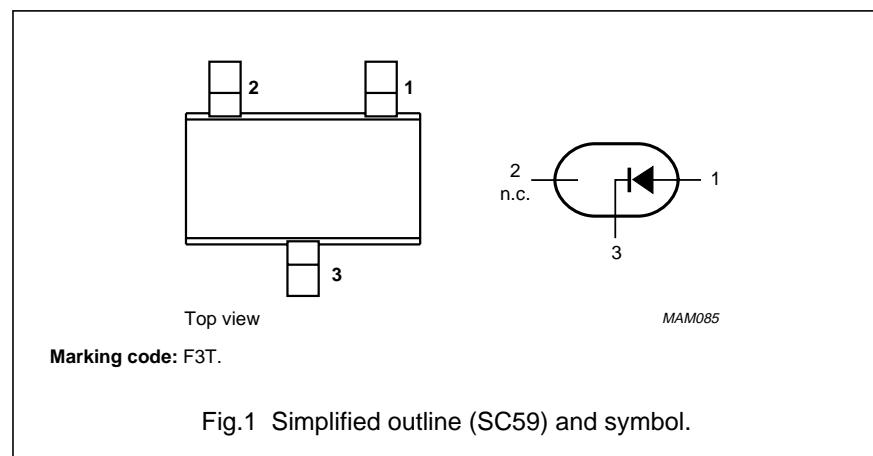


Fig.1 Simplified outline (SC59) and symbol.

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V_{RRM}	repetitive peak reverse voltage		–	85	V
V_R	continuous reverse voltage		–	80	V
I_F	continuous forward current	see Fig.2; note 1	–	215	mA
I_{FRM}	repetitive peak forward current		–	500	mA
I_{FSM}	non-repetitive peak forward current	square wave; $T_j = 25^\circ\text{C}$ prior to surge $t = 1 \mu\text{s}$ $t = 1 \text{ s}$	–	4	A
P_{tot}	total power dissipation	$T_{amb} = 25^\circ\text{C}$; note 1	–	250	mW
T_{stg}	storage temperature		–65	+150	°C
T_j	junction temperature		–	150	°C

Note

1. Device mounted on an FR4 printed-circuit board.

High-speed diode

1PS193

ELECTRICAL CHARACTERISTICS $T_j = 25^\circ\text{C}$; unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	TYP.	MAX.	UNIT
V_F	forward voltage	see Fig.3 $I_F = 1 \text{ mA}$ $I_F = 10 \text{ mA}$ $I_F = 50 \text{ mA}$ $I_F = 100 \text{ mA}$	610 740 — —	— — 1.0 1.2	mV mV V V
I_R	reverse current	see Fig.4 $V_R = 25 \text{ V}$ $V_R = 80 \text{ V}$ $V_R = 25 \text{ V}; T_j = 150^\circ\text{C}$ $V_R = 80 \text{ V}; T_j = 150^\circ\text{C};$	— — — —	30 0.5 30 100	nA μA μA μA
C_d	diode capacitance	$f = 1 \text{ MHz}; V_R = 0$; see Fig.5	—	1.5	pF
t_{rr}	reverse recovery time	when switched from $I_F = 10 \text{ mA}$ to $I_R = 10 \text{ mA}$; $R_L = 100 \Omega$; measured at $I_R = 1 \text{ mA}$; see Fig.6	—	4	ns
V_{fr}	forward recovery voltage	when switched from $I_F = 10 \text{ mA}$; $t_p = 20 \text{ ns}$; see Fig.7	—	1.75	V

THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
$R_{th j\text{-tp}}$	thermal resistance from junction to tie-point		250	K/W
$R_{th j\text{-a}}$	thermal resistance from junction to ambient	note 1	500	K/W

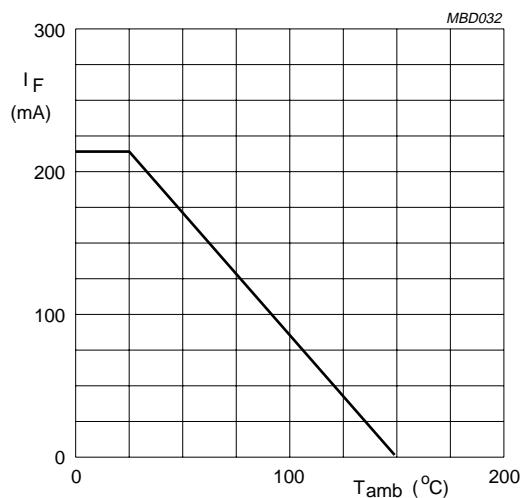
Note

1. Device mounted on an FR4 printed-circuit board.

High-speed diode

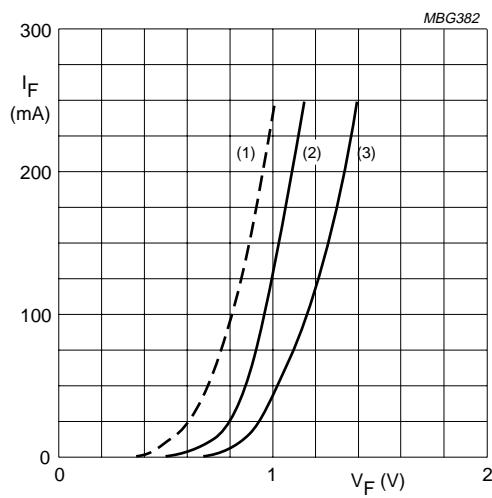
1PS193

GRAPHICAL DATA



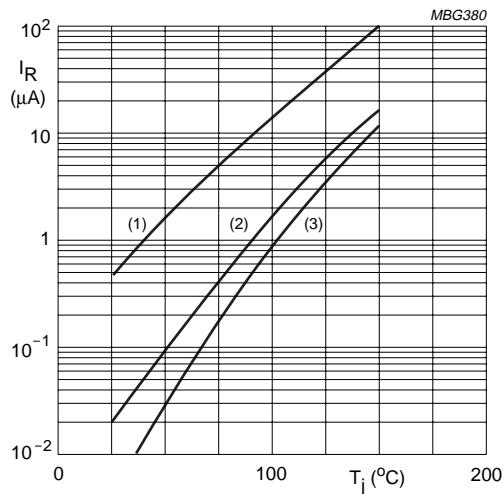
Device mounted on an FR4 printed-circuit board.

Fig.2 Maximum permissible continuous forward current as a function of ambient temperature.



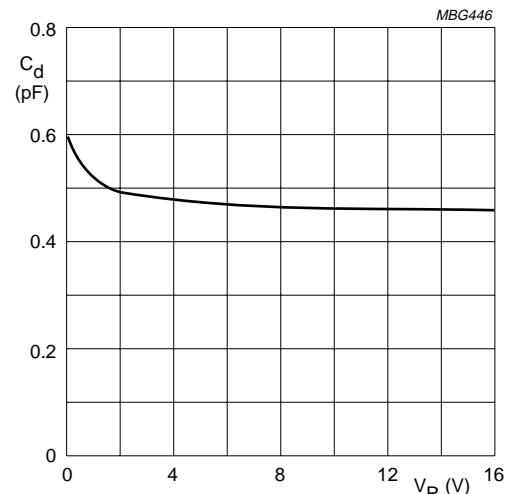
- (1) $T_j = 150 \text{ }^\circ\text{C}$; typical values.
- (2) $T_j = 25 \text{ }^\circ\text{C}$; typical values.
- (3) $T_j = 25 \text{ }^\circ\text{C}$; maximum values.

Fig.3 Forward current as a function of forward voltage.



- (1) $V_R = 80 \text{ V}$; maximum values.
- (2) $V_R = 80 \text{ V}$; typical values.
- (3) $V_R = 25 \text{ V}$; typical values.

Fig.4 Reverse current as a function of junction temperature.



$f = 1 \text{ MHz}; T_j = 25 \text{ }^\circ\text{C}$.

Fig.5 Diode capacitance as a function of reverse voltage; typical values.

High-speed diode

1PS193

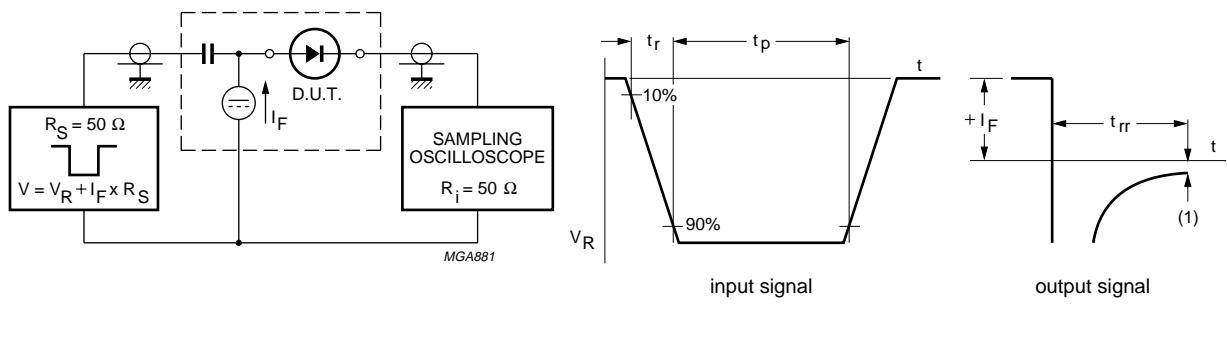
(1) $I_R = 1 \text{ mA}$.

Fig.6 Reverse recovery voltage test circuit and waveforms.

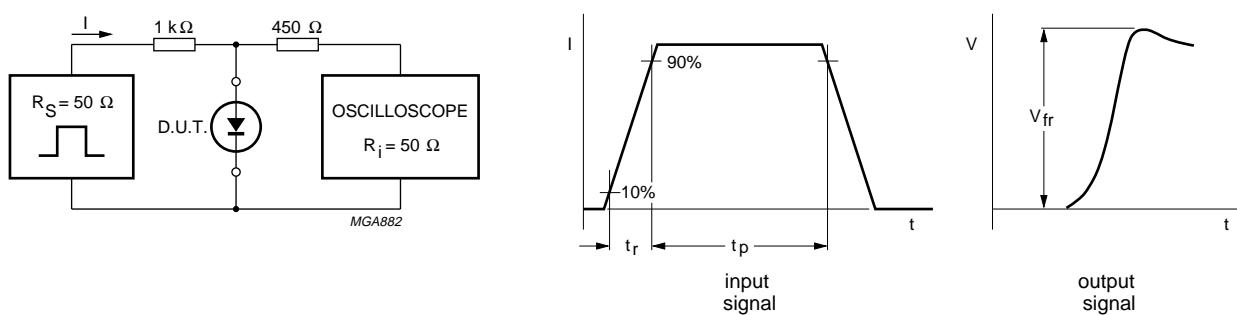
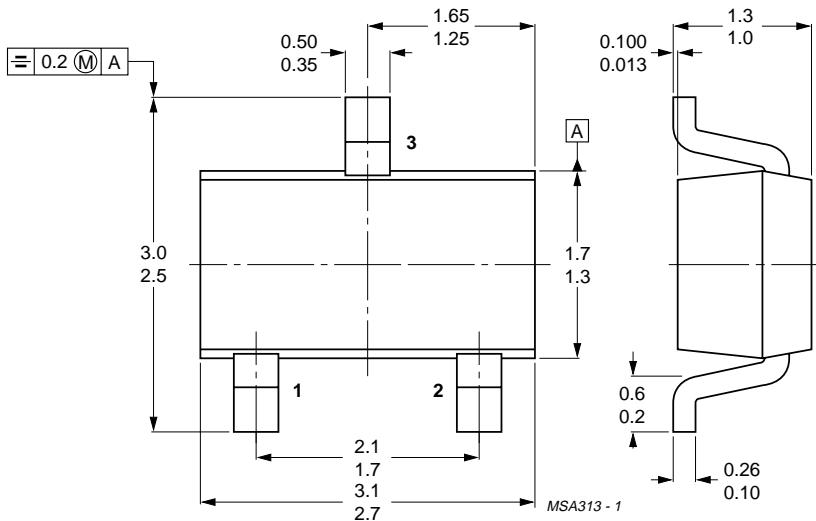


Fig.7 Forward recovery voltage test circuit and waveforms.

High-speed diode

1PS193

PACKAGE OUTLINE



Dimensions in mm.

Fig.8 SC59.

DEFINITIONS

Data Sheet Status	
Objective specification	This data sheet contains target or goal specifications for product development.
Preliminary specification	This data sheet contains preliminary data; supplementary data may be published later.
Product specification	This data sheet contains final product specifications.
Limiting values	
Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.	
Application information	
Where application information is given, it is advisory and does not form part of the specification.	

LIFE SUPPORT APPLICATIONS

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